



## TO-126 Plastic-Encapsulated Transistors

### 2SD886 TRANSISTOR (NPN)

#### FEATURES

Power dissipation

$P_{CM}$ : 1 W ( $T_{amb}=25^\circ\text{C}$ )

Collector current

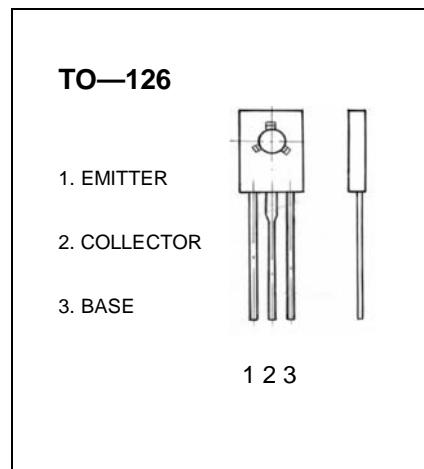
$I_{CM}$ : 3 A

Collector-base voltage

$V_{(BR)CBO}$ : 50 V

Operating and storage junction temperature range

$T_J, T_{stg}$ : -55°C to +150°C



#### ELECTRICAL CHARACTERISTICS ( $T_{amb}=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Collector-base breakdown voltage	$V_{(BR)CBO}$	$I_C=100\mu\text{A}, I_E=0$	50			V
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C=5\text{mA}, I_B=0$	50			V
Emitter-base breakdown voltage	$V_{(BR)EBO}$	$I_E=100\mu\text{A}, I_C=0$	5			V
Collector cut-off current	$I_{CBO}$	$V_{CB}=50\text{V}, I_E=0$			1	$\mu\text{A}$
Emitter cut-off current	$I_{EBO}$	$V_{EB}=3\text{V}, I_C=0$			1	$\mu\text{A}$
DC current gain	$h_{FE(1)}$	$V_{CE}=2\text{V}, I_C=20\text{mA}$	100			
	$h_{FE(2)}$	$V_{CE}=2\text{V}, I_C=1\text{A}$	100		400	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C=2\text{A}, I_B=200\text{mA}$			0.5	V
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C=2\text{A}, I_B=200\text{mA}$			2	V
Transition frequency	$f_T$	$V_{CE}=5\text{V}, I_C=100\text{mA}$		80		MHz
Collector output capacitance	$C_{ob}$	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$		45		pF

# Typical Characteristics

**2SD886**

Fig.1 Static characteristics

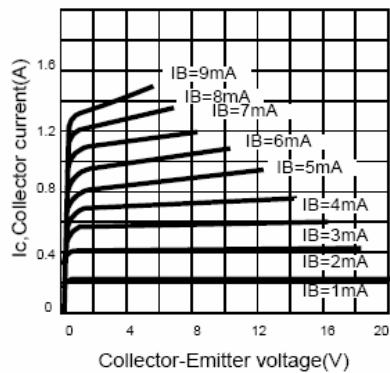


Fig.2 Derating curve of safe operating areas

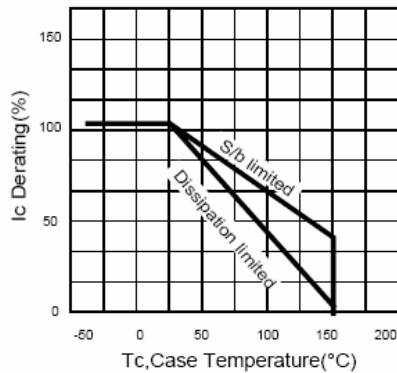


Fig.3 Power Derating

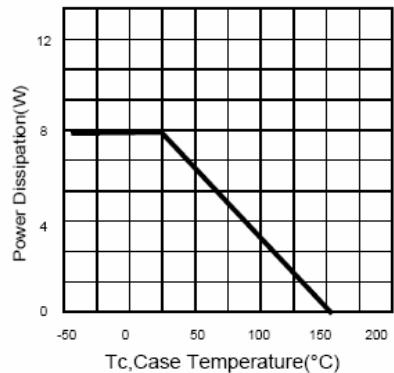


Fig.4 Collector Output capacitance

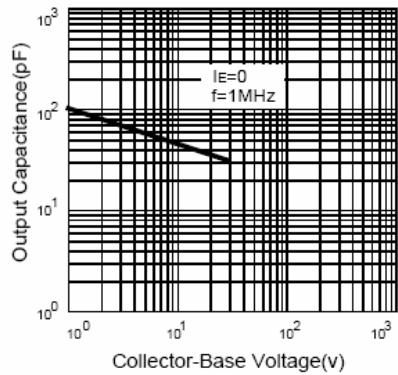


Fig.5 Current gain-bandwidth product

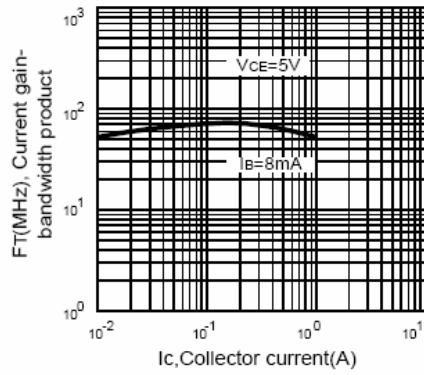


Fig.6 Safe operating area

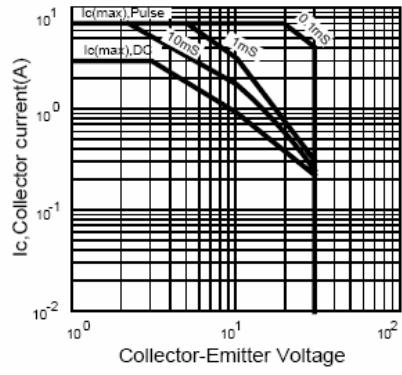


Fig.7 DC current gain

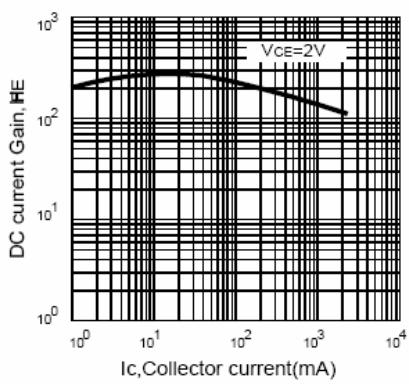


Fig.8 Saturation Voltage

